

Notice of References Cited

Application/Control No.

10/713,257

Applicant(s)/Patent Under
Reexamination
TERAUE, EIJI

Examiner

Allen H. Nguyen

Art Unit

2625

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0006218	01-2002	Sako, Tsukasa	382/132
*	B	US-4,338,636	07-1982	Yamada et al.	358/451
*	C	US-6,453,078	09-2002	Bubie et al.	382/305
*	D	US-5,109,281	04-1992	Kobori et al.	358/296
*	E	US-2002/0028020	03-2002	Fujiwara et al.	382/190
*	F	US-4,823,289	04-1989	Hirosawa et al.	396/551
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.